

# **FPN430** FPN430A



# **PNP Low Saturation Transistor**

These devices are designed for high current gain and low saturation voltage with collector currents up to 2.0 A continuous. Sourced from Process PB.

# **Absolute Maximum Ratings\***

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
$V_{CEO}$	Collector-Emitter Voltage	30	V
V <sub>CBO</sub>	Collector-Base Voltage	35	V
V <sub>EBO</sub>	Emitter-Base Voltage	5.0	V
Ic	Collector Current - Continuous	2.0	A
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

<sup>\*</sup>These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

- 1) These ratings are based on a maximum junction temperature of 150 degrees C.
  2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
  3) All voltages (V) and currents (A) are negative polarity for PNP transistors.

## **Thermal Characteristics**

TA = 25°C unless otherwise noted

Symbol	Characteristic	Max	Units	
		FPN430 / FPN430A		
P <sub>D</sub>	Total Device Dissipation	1.0	W	
R <sub>θJC</sub>	Thermal Resistance, Junction to Case	50	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	125	°C/W	

# **PNP Low Saturation Transistor**

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Min Max Units

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**Parameter** 

TA = 25°C unless otherwise noted

**Test Conditions** 

OFF CHA	RACTERISTICS				
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$BV_CEO$	Collector-Emitter Breakdown	$I_{C} = 10 \text{ mA}, I_{B} = 0$	30		V
	Voltage	, -			
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	$I_{C} = 100  \mu A, I_{E} = 0$	35		V
		· · · ·			
$BV_{EBO}$	Emitter-Base Breakdown Voltage	$I_E = 100  \mu A,  I_C = 0$	5.0		V
I <sub>CBO</sub>	Collector Cutoff Current	$V_{CB} = 30 \text{ V}, I_{E} = 0$		100	nA
		$V_{CB} = 30 \text{ V}, I_{E} = 0, T_{A} = 100^{\circ}\text{C}$		10	μΑ
I <sub>EBO</sub>	Emitter Cutoff Current	$V_{EB} = 4.0 \text{ V}, I_{C} = 0$		100	nA

## ON CHARACTERISTICS\*

Symbol

h <sub>FE</sub>	DC Current Gain	$I_C = 100 \text{ mA}, V_{CE} = 2.0 \text{ V}$	430	100		
			430A	250		
		$I_C = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}$		60		
		$I_C = 2.0 \text{ A}, V_{CE} = 2.0 \text{ V}$		40		
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$I_C = 1.0 \text{ A}, I_B = 100 \text{ mA}$	430		500	mV
-(,			430A		450	mV
		$I_C = 2.0 \text{ A}, I_B = 200 \text{ mA}$			800	mV
V <sub>BE(sat)</sub>	Base-Emitter Saturation Voltage	$I_C = 1.0 \text{ A}, I_B = 100 \text{ mA}$			1.25	V
V <sub>BE(on)</sub>	Base-Emitter Saturation Voltage	$I_C = 1.0 \text{ A}, V_{CE} = 2.0 \text{ V}$			1.0	V

## SMALL SIGNAL CHARACTERISTICS

Cobo	Output Capacitance	$V_{CB} = 10 \text{ V}, I_E = 0, f = 1.0 \text{ MHz}$		25	pF
F <sub>T</sub>	Transition Frequency	$I_C = 100 \text{ mA}, V_{CE} = 5.0 \text{ V},$ f = 100  MHz	100		MHz

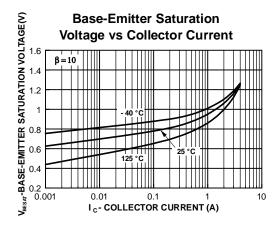
<sup>\*</sup>Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%

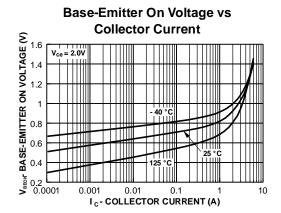
**NOTE:** All voltages (V) and currents (A) are negative polarity for PNP transistors.

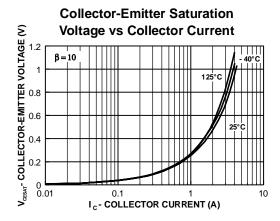
## **PNP Low Saturation Transistor**

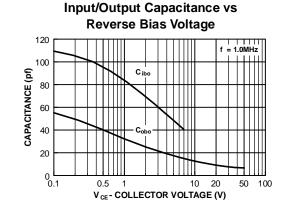
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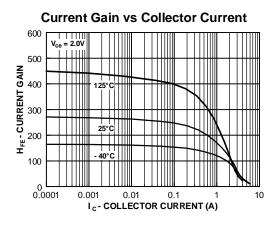
# **Typical Characteristics**

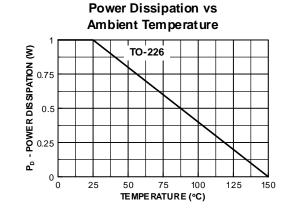












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